



General Description

The QN3107M6N is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The QN3107M6N meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Green Device Available

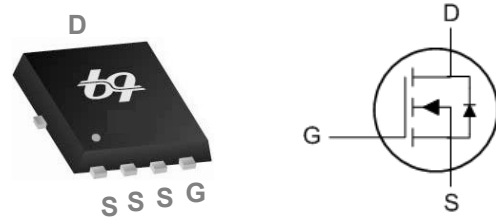
Product Summary

| BVDSS | RDSON (VGS=10V) | ID (Tc=25°C) |
|-------|--------------------|-----------------|
| 30V | 2.6mΩ | 110A |

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

PRPAK 5X6 Pin Configuration



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|---------------------------------------|--|------------|-------|
| V _{DS} | Drain-Source Voltage | 30 | V |
| V _{GS} | Gate-Source Voltage | ±20 | V |
| I _D @T _C =25°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 110 | A |
| I _D @T _C =100°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 70 | A |
| I _D @T _A =25°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 22 | A |
| I _D @T _A =70°C | Continuous Drain Current, V _{GS} @ 10V ¹ | 17 | A |
| I _{DM} | Pulsed Drain Current ² | 220 | A |
| EAS | Single Pulse Avalanche Energy ³ | 155.1 | mJ |
| I _{AS} | Avalanche Current | 55.7 | A |
| P _D @T _C =25°C | Total Power Dissipation ⁴ | 50 | W |
| P _D @T _A =25°C | Total Power Dissipation ⁴ | 2.0 | W |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C |
| T _J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|------------------|--|------|------|------|
| R _{θJA} | Thermal Resistance Junction-Ambient ¹ | --- | 62 | °C/W |
| R _{θJC} | Thermal Resistance Junction-Case ¹ | --- | 2.5 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------|--|--|------|------|-----------|----------------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 30 | --- | --- | V |
| $\Delta BV_{DSS}/\Delta T_J$ | BVDSS Temperature Coefficient | Reference to 25°C , $I_D=1\text{mA}$ | --- | 0.01 | --- | $V/^\circ\text{C}$ |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance ² | $V_{GS}=10V, I_D=30A$ | --- | 2.1 | 2.6 | m Ω |
| | | $V_{GS}=4.5V, I_D=15A$ | --- | 2.9 | 3.8 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}, I_D=250\mu A$ | 1.2 | --- | 2.5 | V |
| $\Delta V_{GS(th)}$ | $V_{GS(th)}$ Temperature Coefficient | | --- | -4.6 | --- | $\text{mV}/^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=24V, V_{GS}=0V, T_J=25^\circ\text{C}$ | --- | --- | 1 | μA |
| | | $V_{DS}=24V, V_{GS}=0V, T_J=55^\circ\text{C}$ | --- | --- | 5 | |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |
| gfs | Forward Transconductance | $V_{DS}=5V, I_D=15A$ | --- | 47.5 | --- | S |
| R_g | Gate Resistance | $V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$ | --- | 0.9 | --- | Ω |
| Q_g | Total Gate Charge (10V) | $V_{DS}=15V, V_{GS}=4.5V, I_D=15A$ | --- | 31.4 | --- | nC |
| Q_g | Total Gate Charge (4.5V) | | --- | 15.1 | --- | |
| Q_{gs} | Gate-Source Charge | | --- | 5.4 | --- | |
| Q_{gd} | Gate-Drain Charge | | --- | 5.2 | --- | |
| $T_{d(on)}$ | Turn-On Delay Time | $V_{DD}=15V, V_{GS}=10V, R_G=3.3\Omega, I_D=15A$ | --- | 10.8 | --- | ns |
| T_r | Rise Time | | --- | 44.6 | --- | |
| $T_{d(off)}$ | Turn-Off Delay Time | | --- | 25.3 | --- | |
| T_f | Fall Time | | --- | 6.1 | --- | |
| C_{iss} | Input Capacitance | $V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$ | --- | 1917 | --- | pF |
| C_{oss} | Output Capacitance | | --- | 1086 | --- | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 47 | --- | |

Guaranteed Avalanche Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|--------|--|--|-------|------|------|------|
| EAS | Single Pulse Avalanche Energy ⁵ | $V_{DD}=25V, L=0.1\text{mH}, I_{AS}=35A$ | 61.25 | --- | --- | mJ |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|--|---|------|------|------|------|
| I_S | Continuous Source Current ^{1,6} | $V_G=V_D=0V$, Force Current | --- | --- | 110 | A |
| I_{SM} | Pulsed Source Current ^{2,6} | | --- | --- | 220 | A |
| V_{SD} | Diode Forward Voltage ² | $V_{GS}=0V, I_S=1A, T_J=25^\circ\text{C}$ | --- | --- | 1.2 | V |
| trr | Reverse Recovery Time | $I_F=15A, dI/dt=100A/\mu s, T_J=25^\circ\text{C}$ | --- | 73.6 | --- | nS |
| Qrr | Reverse Recovery Charge | | --- | 62.3 | --- | nC |

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1\text{mH}$
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The Min. value is 100% EAS tested guarantee.
- 6.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

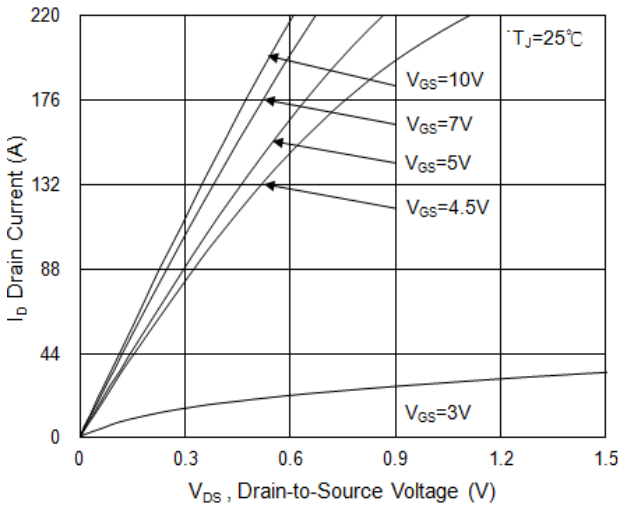


Fig.1 Typical Output Characteristics

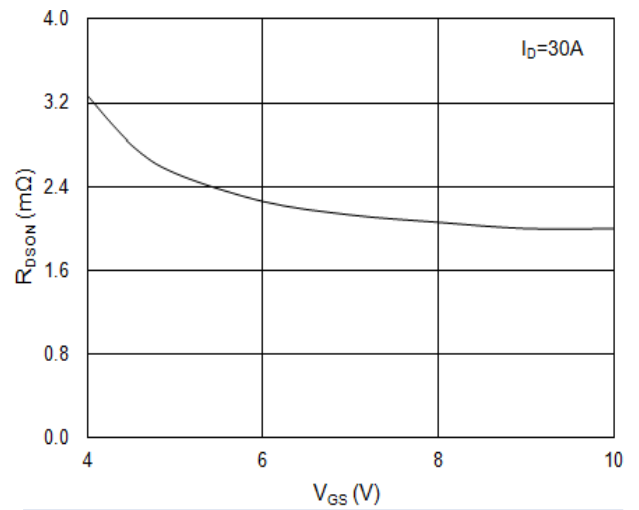


Fig.2 On-Resistance vs. Gate-Source

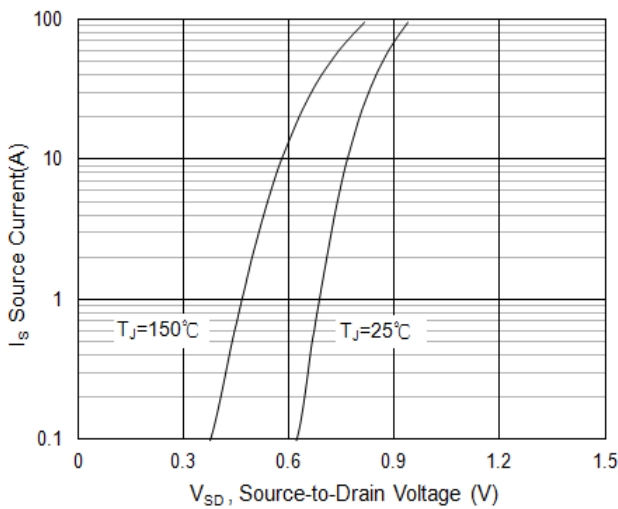


Fig.3 Forward Characteristics of Reverse

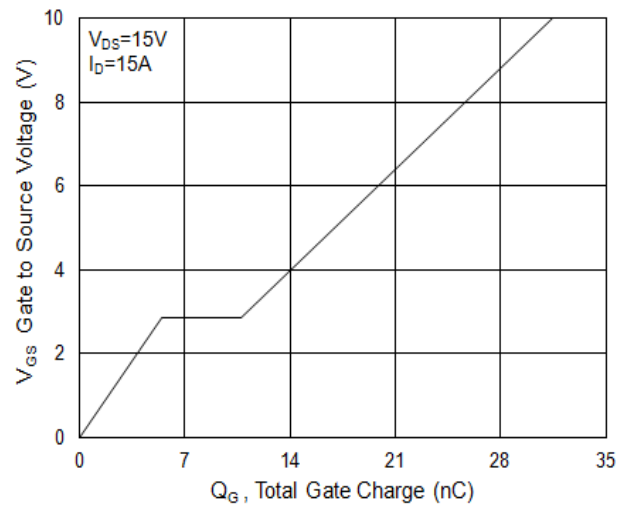


Fig.4 Gate-Charge Characteristics

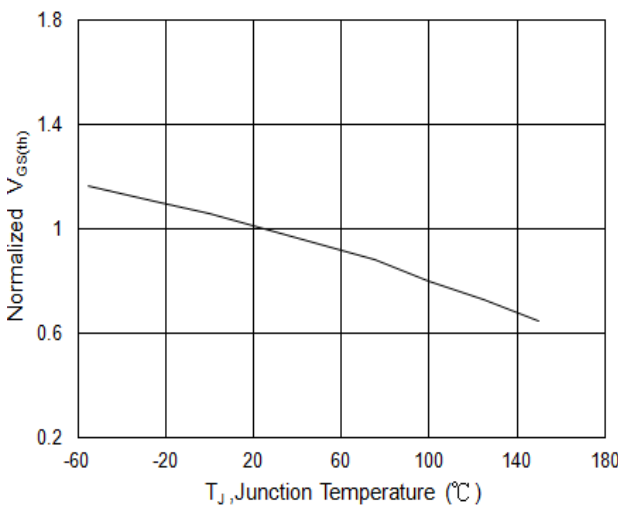


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

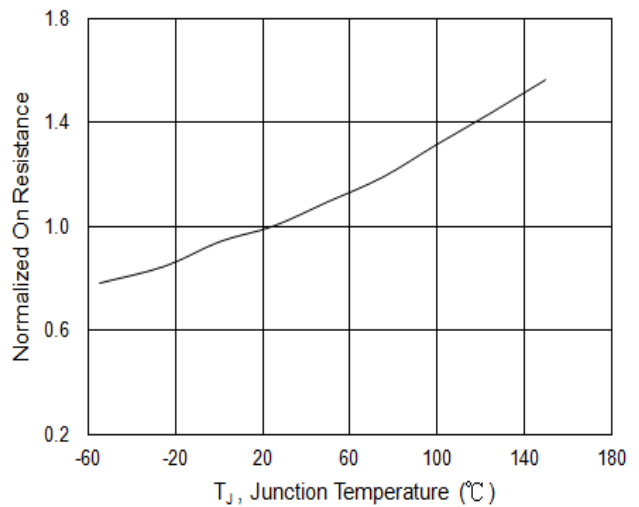


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

N-Channel 30V Fast Switching MOSFET

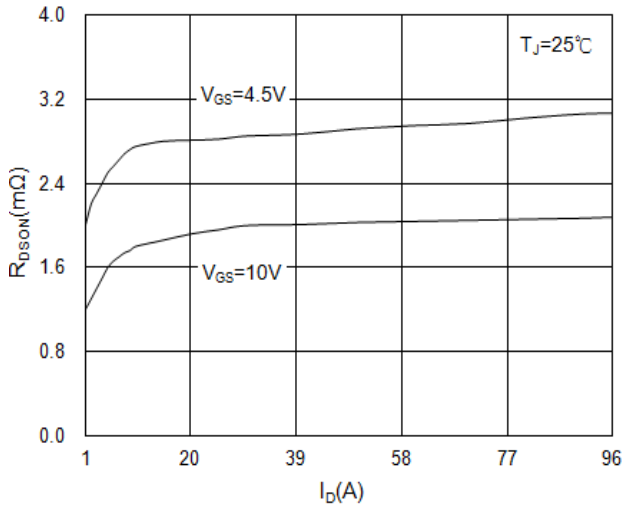


Fig.7 Drain-Source On-State Resistance

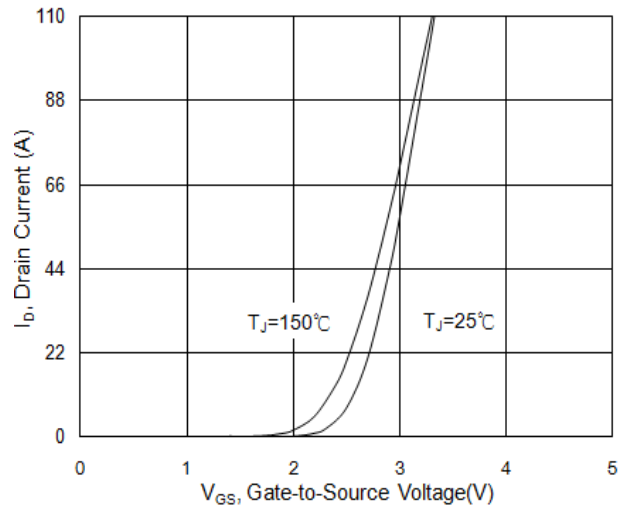


Fig.8 Transfer Characteristics

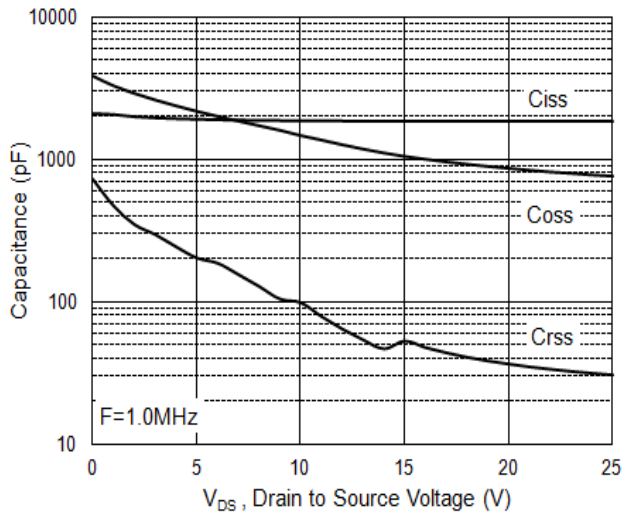


Fig.9 Capacitance

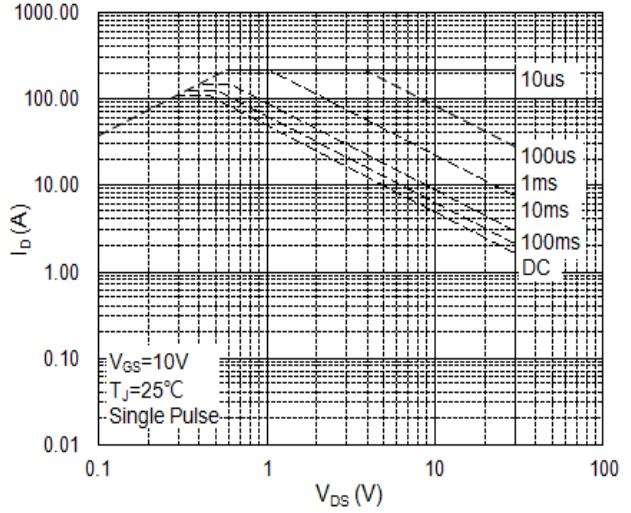


Fig.10 Safe Operating Area

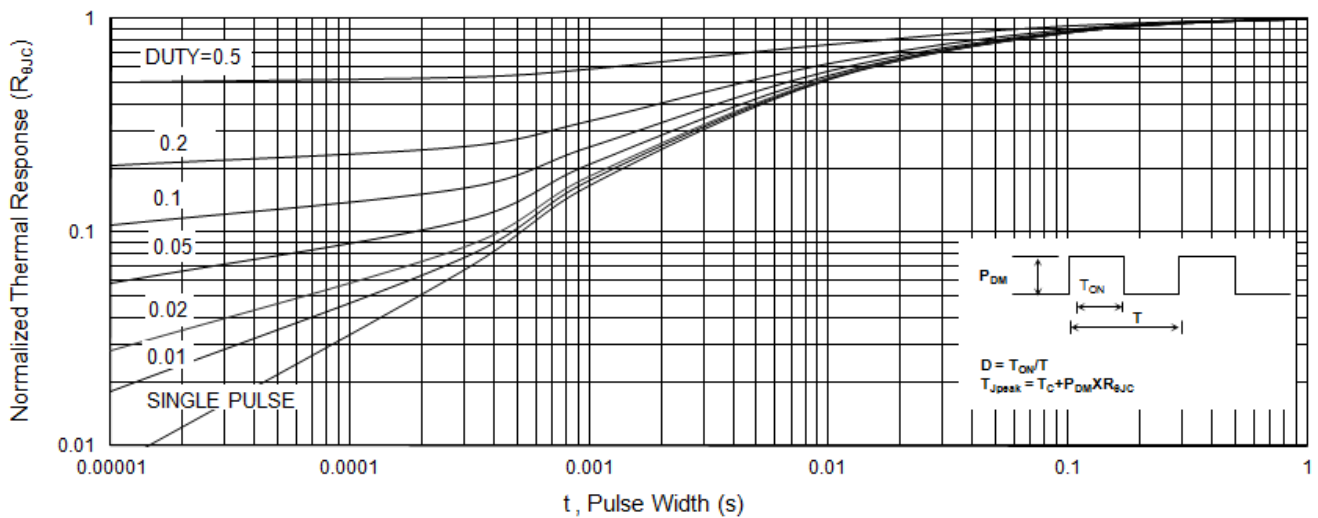


Fig.11 Transient Thermal Impedance

单击下面可查看定价，库存，交付和生命周期等信息

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